

# Model 5700 DC Power Supply Test System



Engineering Characterization & Design Verification Functional Test

## Features

- PowerScope 200MS/sec waveform digitizer for capturing fast transients
- Unlimited voltage, current & timing measurements relative to digital signals.
- Library of design verification test routines reduces program development time
- Configuration flexibility includes 3rd- party instruments

## Applications

The Model 5700 is designed to yield comprehensive test data on a wide range of AC-DC and DC-DC power supplies with a minimum of programming effort. Such characterization testing is typically done in an engineering design-verification laboratory where the user's own designs or vendor prototypes are evaluated. This type of extensive testing is also often required for high-reliability power supplies used in medical, telecommunication, space and avionic applications.

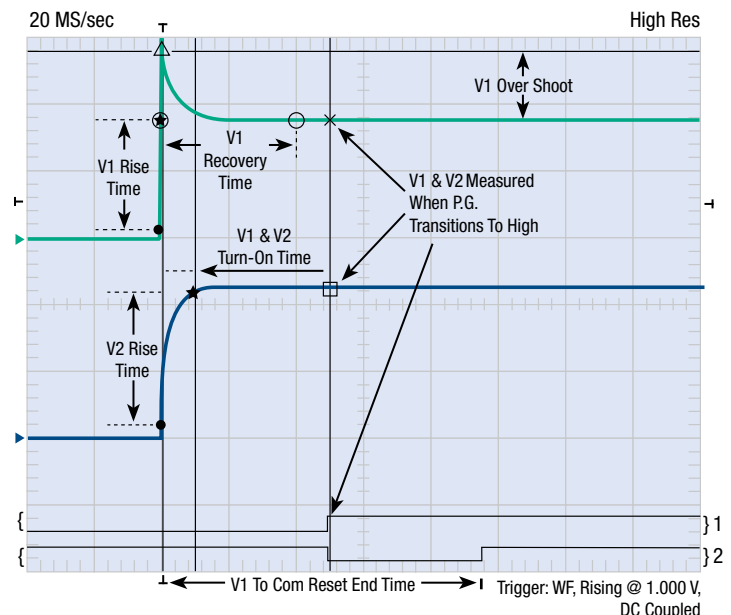
## PowerScope High-Speed Digitizer

The Model 5700 Digital Measurement System (DMS), consists of a 2x16, 100MHz multiplexer combined with 2 moderate-speed waveform digitizers. The DMS provides highly accurate channel-channel timing measurements and corresponding waveform displays. Should more than 16-input measurement channels be required, multiple 15-input expansion chassis can be added to the system.

A high-speed waveform digitizer supplements the above Digital Measurement System on the Model 5700. It provides three 8-bit analog signal digitizing channels with 200MS/Sec sample rate and 16 channels of digital signal input. This combination of multi-channel measurement circuits allows high-speed digital and analog information to be synchronously captured, displayed and measured. With up to 32MS/channel memory, the PowerScope can capture fast, non-repetitive transients even with relatively long separation from their triggering event.



Model 5700 in a 3-bay cabinet



Unlimited cursors and markers identify the exact point where the measurement is to be taken.

## Design Verification Test Routines

To complement the powerful digital measurement system, a special suite of test routines are provided to determine power supply performance characteristics far beyond that available on a basic production tester. For instance, more than 20 different measurements can be extracted from each waveform capture and channel-to-channel measurements are all straight forward to execute. One example of this capability is sweep tests where one parameter, such as efficiency, is plotted across the full range of another parameter like output voltage or power. This test can now be programmed and executed in minutes rather than the hours and days required by previous generation test systems.

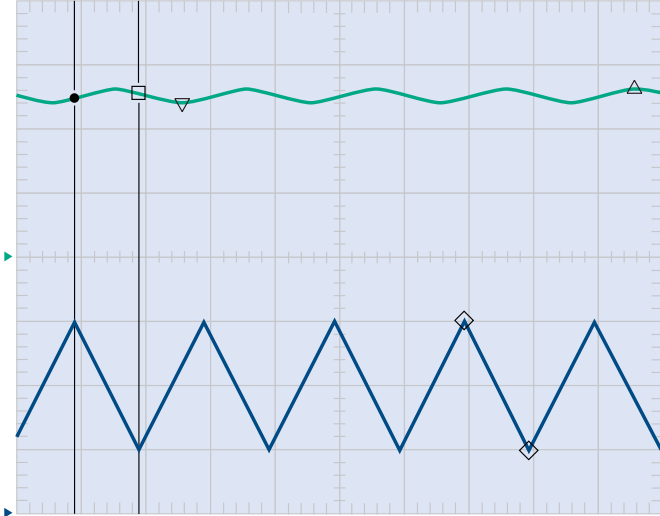
<b>MODEL 5700 EMPOWER TEST CAPABILITY</b>			
<b>General Tests</b>	Output Accuracy	<b>Timing Tests</b>	Rise-Time
	Output Adjustment		Fall Time
	Output Trim		Turn-On Time
	RMS Noise/Ripple		Turn-On Sequence (load-to-load timing)
<b>Regulation Tests</b>	Operator Data Entry, Test, Visual Acceptance & Instructions	<b>Control</b>	Turn-Off Time
	Power Fail Signal		Turn-Off Sequence (load-to-load timing)
	Power Good Signal		Hold-Up Time
	P/ S ON Signal		Transient Recovery Time
<b>Protection Tests</b>	Operator Waveform Inspection	<b>Output Measurement</b>	Overshoot Width
	Multi-Measure		Undershoot Width
	Monotonicity		Pulsewidth as Time
	Shock/ Shake Test		Pulsewidth as Frequency
<b>Dynamic Tests</b>	Load Regulation	<b>Real Time (Manual Control)</b>	Multiple-Timing (Unlimited-Cursors)
	Cross-Load Regulation		Single Digital Control
	Voltage Regulation		BYTE/WORD Digital Control
	Current Regulation		OVP (OverVoltage) Driver
<b>Dynamic Tests</b>	Power Regulation	<b>Real Time (Manual Control)</b>	OTP (OverTemperature) Driver
	Over-Current Ramp Protection		Start/ Stop/ Pass/ Fail/ Busy/ Ready Controls
	High Accuracy Over-Current Slew Protection		8 Measurement Channels Control for Vout & ID Outputs
	Over-Voltage Protection (no scope required)		Voltage
<b>Dynamic Tests</b>	Under-Voltage Protection	<b>Real Time (Manual Control)</b>	Current
	High Accuracy Over-Power Slew Protection		Power
	Over-Power Protection		Digital State
	Short-Circuit Protection (up to 100A)		DC Positive Peak
<b>Dynamic Tests</b>	Over-Temperature (via relay control)	<b>Real Time (Manual Control)</b>	DC Negative Peak
	Single Load Transient		Voltage & Current Waveform Capture and Analysis
	Synchronized Multi-Output Load Transient		Frequency
	Worst-Case Dynamic Transient (Frequency & Duty Cycle)		Mean
<b>Dynamic Tests</b>	Overshoot	<b>Real Time (Manual Control)</b>	RMS AC Coupled
	Undershoot		RMS DC Coupled
	Settle/ Recovery Voltage		Peak Max
	Settle/ Recovery Time		Peak Min
<b>Dynamic Tests</b>		<b>Real Time (Manual Control)</b>	Peak-Peak
			Peak Absolute
			Time at Event
			Timing as Frequency
<b>Dynamic Tests</b>		<b>Real Time (Manual Control)</b>	Measurement at Event
			Interactive Real-Time Hardware Control Step-by-step
			Interactive Test Program Break Point for Fixture & UUT Debug

## TEST REPORT EXAMPLES

### Triangular Current Waveform Measurements

Vout Max	4.700 V	5.155 V	5.300 V	Pass
Vout Min	4.700 V	4.747 V	5.300 V	Pass
Iout Max	2.950 A	3.030 A	3.050 A	Pass
Iout Min	950.000 mA	1.016 A	1.050 A	Pass
Vout @ 1st Iout Max	4.700 V	4.851 V	5.300 V	Pass
Vout @ 1st Iout Min	4.700 V	5.062 V	5.300 V	Pass
Iout Frequency	495.000 Hz	497.512 Hz	505.000 Hz	Pass

50 KS/sec



1.000 mS/div

Trigger: System Trigger

Wf1, (Current): 1 A/div, 0.0A @ -4 Div. Wf2, (Voltage): 2 V/div, 0.0V @ 0 Div.

Vout Max: Max =  $\Delta$  Wf2: Voltage @ 9.560 mS, 5.155 V

Vout Min: Min =  $\nabla$  Wf2: Voltage @ 2.560 mS, 4.747 V

Iout Max: Max =  $\diamond$  Wf1: Current @ 6.940 mS 3.030 A

Iout Min: Min =  $\diamond$  Wf1: Current @ 7.940 mS 1.016 A

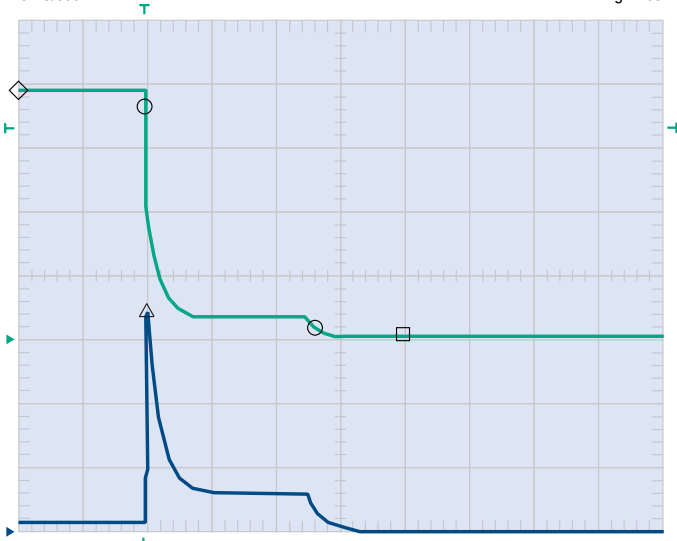
Vout @ 1st Iout Max: Min =  $\bullet$  Wf1: Current @ 900.000  $\mu$ S, 4.851 V

Vout @ 1st Iout Min: Max =  $\square$  Wf1: Current @ 1.900 mS, 5.062 V

### Short-Circuit Test

UUT Short-Circuit Response Time	0.000 S	2.592 mS	4.000 mS	Pass
Max Short-Circuit Current	3.340 A	69.034 A	75.000 A	Pass
Vout Before Short-Circuit	18.525 V	19.348 V	20.475 V	Pass
Vout 4mS After Short Circuit	0.000 V	100.637 mV	1.000 V	Pass

5MS/sec High Res



1.000 mS/div

Trigger: WF 1, Falling @ 16.500 V. DC Coupled

Wf1, Chn 001, 5V/div. Wf2, Chn 002, 20 A/div.

UUT Short-Circuit Response Time: Start =  $\circ$  Wf1: Chn 001 @ 1.996 mS, 18.412 V  
Stop =  $\circ$  Wf1: Chn 001 @ 4.589 mS, 0.971 V

Max Short-Circuit Current: Max =  $\Delta$  Wf2: Chn 002 @ 2.020 mS, 69.034 A

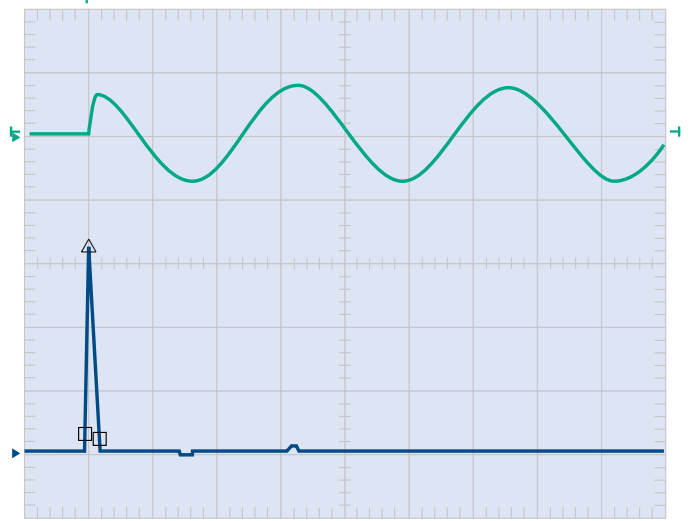
Vout Before Short-Circuit: Mean =  $\diamond$  Wf1: Chn 001 @ 0.000 S, 19.348 V

Vout 4mS After Short-Circuit: Event =  $\square$  Wf1: Chn 001 @ 6.000 mS, 100.637 mV

### Inrush Waveform Measurement

Inrush Current	40.000 A	65.071 A	76.000 A	Pass
Inrush Current Width	500.000 $\mu$ S	741.000 $\mu$ S	2.000 mS	Pass
Vin	262.000 V	263.682 V	266.000 V	Pass
Vin Frequency	59.000 Hz	60.588 Hz	61.000 Hz	Pass

1MS/sec High Res



5.000 mS/div

Trigger: WF 3, Rising @ 30.012 V. DC Coupled

Wf1, Chn 003, 20A/div. Wf3, Fixed, 500 V/div.

Inrush Current: Max =  $\Delta$  Wf1: Chn 005 @ 5.201 mS, 65.071 A

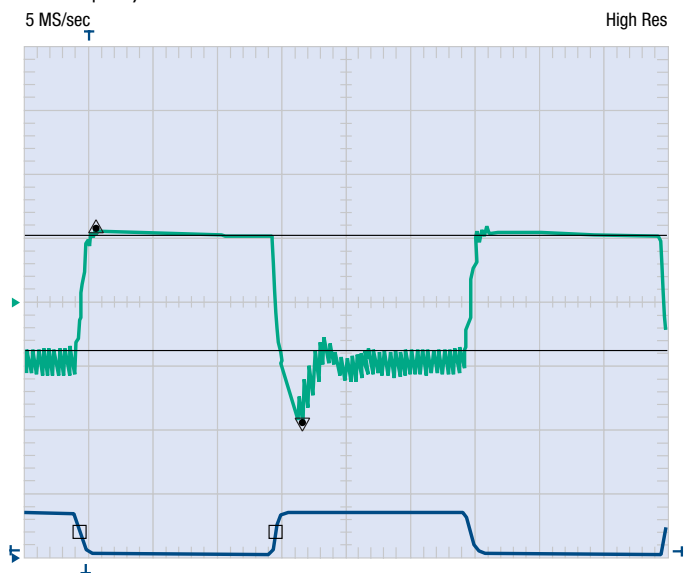
Inrush Current Width: Start =  $\square$  Wf1: Chn 003 @ 4.925 mS, 6.762 A: Stop =  $\square$

Wf1: Chn 003 @ 5.666 mS, 5.505 A

### Dynamic Test

Vout Max	0.000 V	239.784 mV	500.000 mV	Pass
Vout High	0.000 V	209.241 mV	500.000 mV	Pass
Vout Min	0.000 V	-371.088 mV	-500.000 mV	Pass
Vout Low	0.000 V	-151.174 mV	-500.000 mV	Pass
Vout Overshoot	0.000 V	31.410 mV	500.000 mV	Pass
Vout Undershoot	0.000 V	145.136 mV	500.000 mV	Pass
Iout Pulse Width	585.000 $\mu$ S	603.800 $\mu$ S	615.000 $\mu$ S	Pass
Iout Frequency	1.650 KHz	1.656 KHz	1.690 KHz	Pass

5 MS/sec High Res



200.000  $\mu$ S/div

Trigger: WF2, Falling @ 500.000 mA DC Coupled

Wf1, Chn 001, 200 mV/div, AC. Wf2, Chn 002, 5 A/div.

Vout Max: Max =  $\Delta$  Wf1: Chn 001 @ 222.400  $\mu$ S, 239.784 mV

Vout High: High = Wf1: Chn 001 @ 0.000 S, 209.241 mV

Vout Min: Min =  $\nabla$  Wf1: Chn 001 @ 866.800  $\mu$ S, -371.088 mV

Vout Low: Low = Wf1: Chn 001 @ 0.000 S, -151.174 mV

Vout Overshoot: Max =  $\bullet$  Wf1: Chn 001 @ 222.400  $\mu$ S, 239.784 mV

Vout Undershoot Min =  $\bullet$  Wf1: Chn 001 @ 866.800  $\mu$ S, -371.088 mV

Iout Pulse Width: Start =  $\square$  Wf2: Chn 002 @ 184.000  $\mu$ S, 1.840 A; Stop =  $\square$  Wf2:

Chn 002 @ 787.800  $\mu$ S, 1.848 A

# Model 5700 Power Supply Test System Specifications

SYSTEM CONTROL	
Rack Server CPU	Intel Dual Core 2.9 GHz
Memory	2 GB
Hard Drive	500GB
Monitor	17" Flat Panel
Accessories	Mouse & Keyboard

SOFTWARE	
Operating System	Win 7 Pro
Test Executive	emPower - An integrated environment for creating, debugging, running and collecting data for power supply functional test. Includes a test routine library, report generator and interactive instrument panels. Fully network compatible
Custom Test Program Languages	To extend the user-modifiable test routine library written in Visual Basic, test programs can also be written in any language supporting MS Active X control interface, including LabVIEW and LabWindows CVI

PHYSICAL	
Connectors	Terminal blocks or Hypertronics
Cabinet Dimensions HWD <sup>1</sup>	72 x 28 x 35in 1829 x 712 x 889mm
Cabinet Weight	~750 lbs/cabinet
Operating Temp.	0 -35° C full power
Input Power	All US and Intl. standards available

MEASUREMENTS			
Basic Digital Measurement Capability	Range	Resolution	Accuracy
Channels	2		
Resolution	16 Bit		
Sample Rate	100KS/Sec		
DC Volts	± 2, 20, 200, 500	0.003% FS	0.01% + 0.01% FS
AC Volts RMS	14, 140 350VRMS	0.004% FS	± 1% R + 0.065% FS
DC Volts Peak	± 20, 200, 500V	0.012% FS	1% R + 0.02% FS
RMS Noise	70mV, 350 mV, 3.5V	0.012% FS	1% R + 0.5 % FS
10 Hz - 100 MHz			
Pk-to-Pk Noise	100mV, 500mV, 5V	0.02% FS	1.0% R + 2.0% FS
5 KHz - 100 MHz			
Frequency	10Hz, 5MHz	1/100ns	0.016% R
Timing	0 to 7 minutes	100ns	0.02% R + 200nsec
Waveform Capture	DC to 100 MHz	0.003%	1% FS
Phase Angle	0 to 360°	1°	± 1% @ 50/60Hz
THD (2 -64th)	0 to 100%	0.01%	1% R
Powerscope High-Frequency Measurement Module		I/O Module (Expandable to 8)	
Channels	3 Analog + 16 Digital	<b>Multiplexer</b>	
Resolution	8-Bit	Input Channels 16, differential	
Sample Rate	200MS/Sec Maximum	Output Channels 2, differential	
DC Accuracy	1.5% Rdg + 1% Rge	Bandwidth (-3db)	
AC Accuracy - DC Coupled or AC Coupled High Impedance	1.5% Rdg + 1% Rge @ 50KHz	Output 1 100MHz	
AC Accuracy - 50 Ohm AC Coupled	1.5% Rdg + 1% Rge @ 2MHz	Output 2 10MHz	
Hardware Ranges+/- V Pk	0.05, 0.125, 0.25, 0.5, 1.25, 2.5, 5, 12.5, 25, 50V	Max Voltage ± 500V	
Memory Capacity	8 MB per channel	Max Current 100mA	
		<b>General Purpose Relays</b>	
		Quantity 8 DPDT	
		Contact Rating 5A, 30VDC or 120/240VAC	
		<b>Relay Drivers</b>	
		Quantity 16	
		Rating 48V @ 500mA	
		<b>Digital Drivers</b>	
		Quantity 16	
		Rating 100mA, 70VDC, 0.5W	
		<b>Digital Receivers</b>	
		Quantity 8	
		Input Voltage ± 10V	
		Accuracy 1%	

## Configuration Flexibility

A wide variety of source and load instruments are available to configure the 5700 system in a single or multiple cabinet form depending on instruments selected.

TYPE	AC/DC SOURCES			MODULAR DC SOURCES	MODULAR DC LOADS			FULL CHASSIS OR CABINET LOADS	
Model Number	5427	5100	9410	6100 (4 Voltage Models)	4100	4200	4350 (3 Power Models)	4700	4760
<b>AC Mode</b>									
Phase	1ø	1ø	1, 2, & 3ø						
Power	2.7kVA	4.5kVA	20, 40, 60, 80kVA						
Voltage	150V 300VRMS	140/280VRMS	320VRMS						
Current	9 & 18ARMS	25/12.5A RMS	30, 60, 80, 120A/ø						
Peak Current	90A	200/100A	90, 180, 270, 360A/ø						
Frequency	40 - 500Hz	40 - 500Hz	45 - 880Hz						
<b>DC Mode</b>									
Power (continued)	2kW	3kW	12, 25, 36, 48kW	450W	300W	300W	150, 300 & 600W	1, 2, 3, 6, 12, 18, 24, 36kW	1, 2, 3, 6, 12, 18, 24, 36kW
Voltage	±212,424VDC	±100, 200, 400VDC	155, 350VRMS	20, 40, 80, 450VDC	450V	120V	500V	120V	600V
Current	±18, 9ADC	50, 25,12.5ADC	50, 25, 12.5ADC	60, 30, 15, 8ADC	60A	60A	30, 60, 120A	200 - 7200A	50 - 1800A
Peak Current	90, 45A	200,200,160A	84,169,252,336ADC						
Chassis Capability				to 6 sources	to 6 loads	to 6 loads	to 16 of the 150 W loads		

\* Request model data sheets for complete specifications. Consult factory for additional instrumentation availability